



N-Channel Enhancement Mode Field Effect Transistor

Product Summary

V_{DS}	150V
I_D	30A
$R_{DS(ON)}$ (at $V_{GS}=10V$)	24m
$R_{DS(ON)}$ (at $V_{GS}=6V$)	26m
100% EAS Tested	
100% V_{DS} Tested	

General Description

Split gate trench MOSFET technology
Low $R_{DS(on)}$

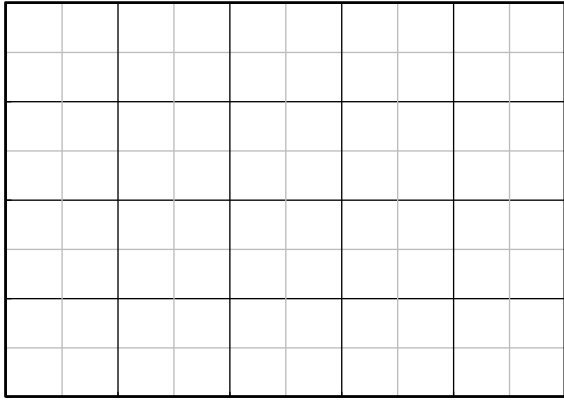


Figure 7. $R_{DS(on)}$ VS Drain Current

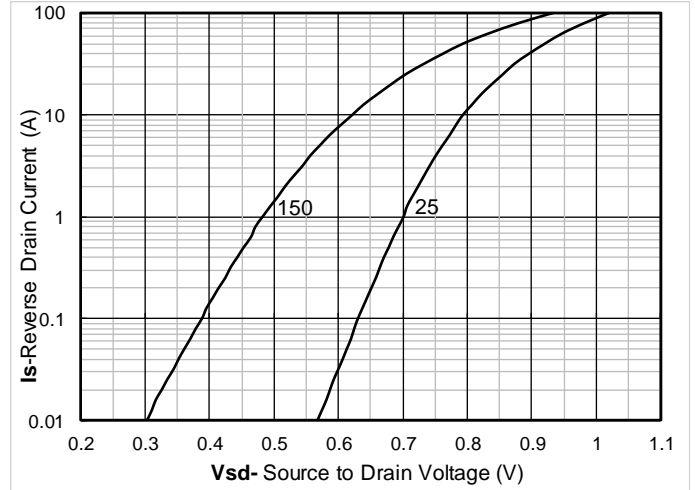


Figure 8. Forward characteristics of reverse diode

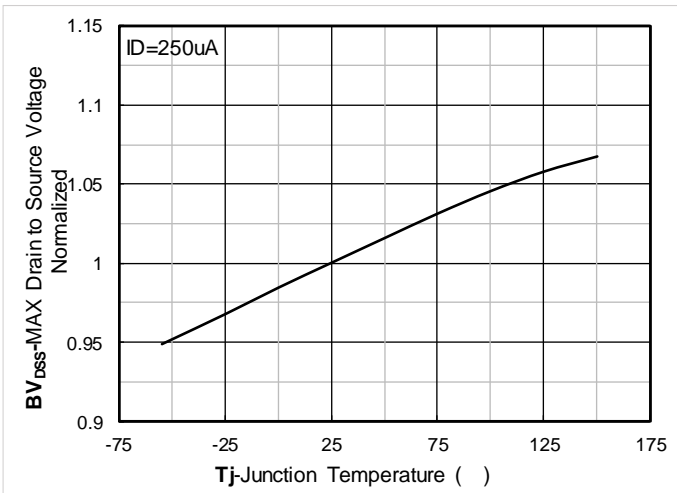


Figure 9. Normalized breakdown voltage

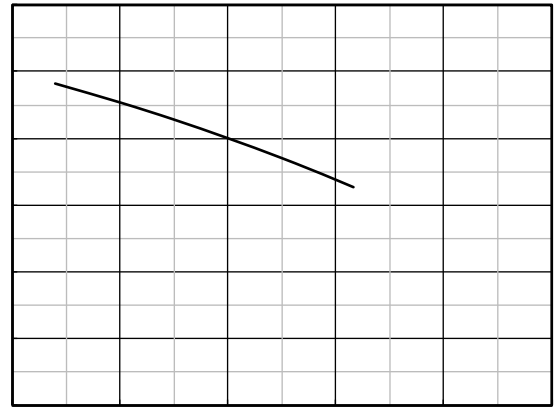


Figure 10. Normalized Threshold voltage

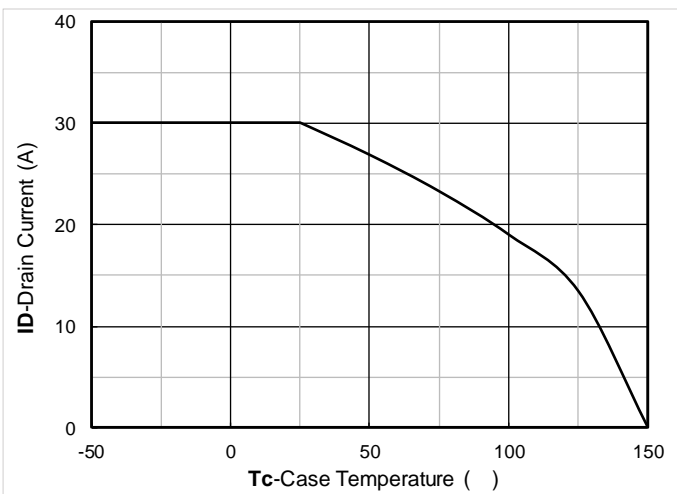


Figure 11. Current dissipation

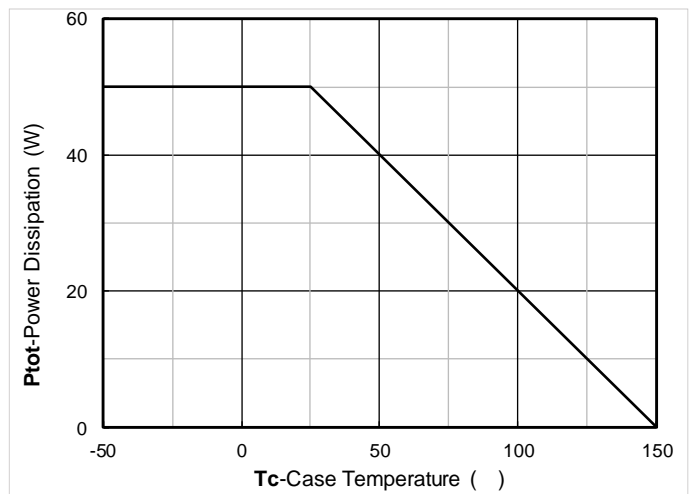


Figure 12. Power dissipation

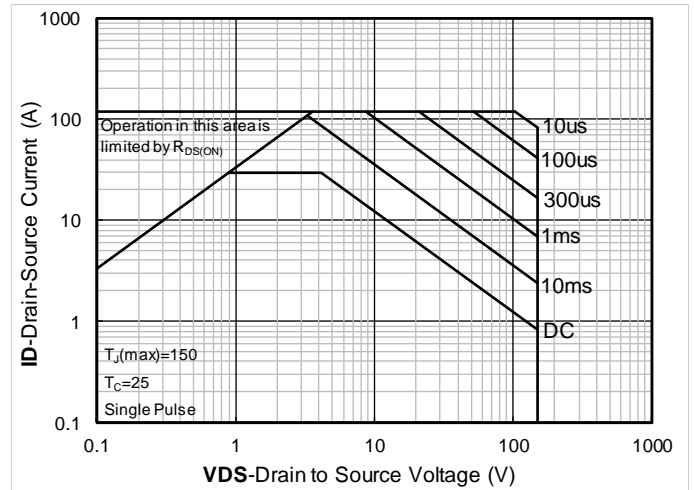


Figure 13. Maximum Transient Thermal Impedance

Figure 14. Safe Operation Area

Test Circuits & Waveforms

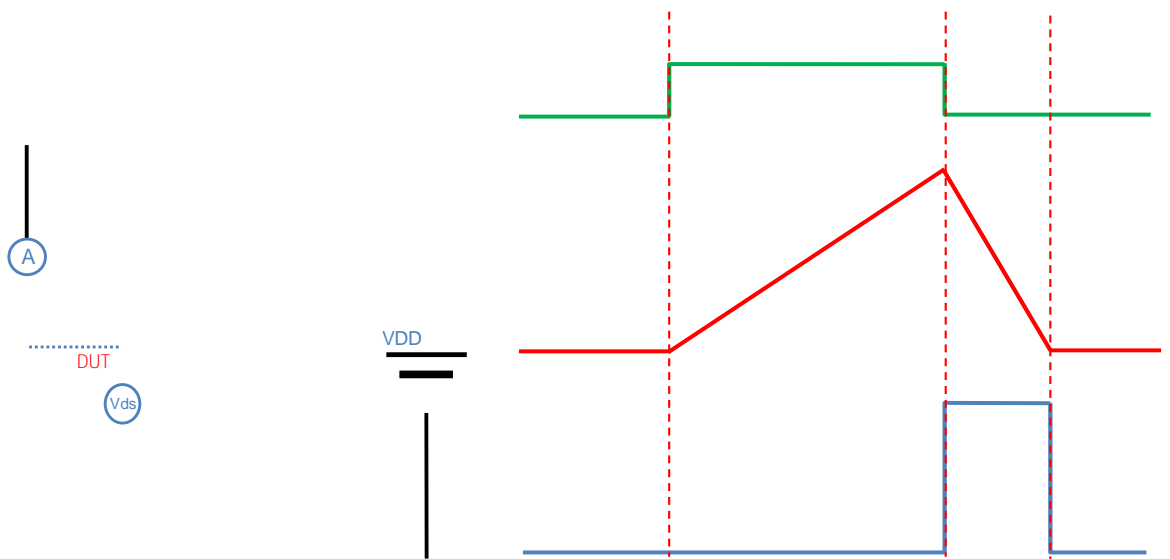


Figure A. Unclamped Inductive Switching (UIS) Test Circuit & Waveform



ITO-220AB-B Package information

